


<b>Search Notes</b> 	<b>Application/Control No.</b> 10692173	<b>Applicant(s)/Patent Under Reexamination</b> CHEN ET AL.
	<b>Examiner</b> Shih, Haoshian	<b>Art Unit</b> 2173

SEARCHED			
Class	Subclass	Date	Examiner
715	724, 769, 512, 523	2/5/2007	HSS
706	47	2/5/2007	HSS

SEARCH NOTES		
Search Notes	Date	Examiner
searched east	2/5/2007	HSS
consulted with Ray Bayerl	2/5/2007	HSS
consulted with Kieu Vu	2/5/2007	HSS

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner